

## Applications

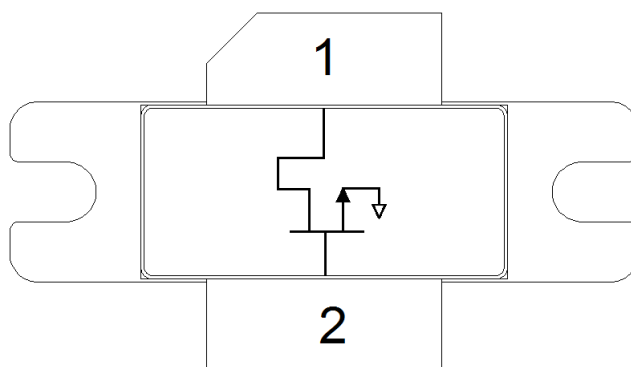
- Military radar
- Civilian radar
- Professional and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- GPS Communications
- Avionics



## Product Features

- Frequency: DC to 2.0 GHz
- Output Power ( $P_{3dB}$ ): 260 W at 1.2 GHz
- Linear Gain: 18 dB at 1.2 GHz
- Operating Voltage: 36 V
- Low thermal resistance package

## Functional Block Diagram



## General Description

The TriQuint T1G2028536-FL is a 285 W ( $P_{3dB}$ ) discrete GaN on SiC HEMT which operates from DC to 2 GHz. The device is constructed with TriQuint's proven TQGaN25HV process, which features advanced field plate techniques to optimize power and efficiency at high drain bias operating conditions. This optimization can potentially lower system costs in terms of fewer amplifier line-ups and lower thermal management costs.

Lead-free and ROHS compliant

Evaluation boards are available upon request.

## Pin Configuration

| Pin No. | Label          |
|---------|----------------|
| 1       | $V_D$ / RF OUT |
| 2       | $V_G$ / RF IN  |
| Flange  | Source         |

## Ordering Information

| Part               | ECCN  | Description                       |
|--------------------|-------|-----------------------------------|
| T1G2028536-FL      | EAR99 | Packaged part<br>Flanged          |
| T1G2028536-FL-EVB1 | EAR99 | 1.2 – 1.4 GHz<br>Evaluation Board |

## Absolute Maximum Ratings

| Parameter                                     | Value         |
|---|---------------|
| Breakdown Voltage ( $V_{DG}$ )                | 145 V (Min.)  |
| Drain Gate Voltage ( $V_{DG}$ )               | 48 V          |
| Gate Voltage Range ( $V_G$ )                  | -7 to 0 V     |
| Drain Current ( $I_D$ )                       | 24 A          |
| Gate Current ( $I_G$ )                        | -57 to 67 mA  |
| Power Dissipation ( $P_D$ )                   | 260 W         |
| RF Input Power, CW,<br>T = 25 °C ( $P_{IN}$ ) | 47 dBm        |
| Channel Temperature ( $T_{CH}$ )              | 275 °C        |
| Mounting Temperature<br>(30 Seconds)          | 320 °C        |
| Storage Temperature                           | -40 to 150 °C |

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

## Recommended Operating Conditions

| Parameter                            | Value         |
|--------------------------------------|---------------|
| Drain Voltage ( $V_D$ )              | 36 V (Typ.)   |
| Drain Quiescent Current ( $I_{DQ}$ ) | 576 mA (Typ.) |
| Peak Drain Current ( $I_D$ )         | 1.33 A (Typ.) |
| Gate Voltage ( $V_G$ )               | -3.0 V (Typ.) |
| Channel Temperature ( $T_{CH}$ )     | 250 °C (Max)  |
| Power Dissipation, CW ( $P_D$ )      | 226 W         |
| Power Dissipation, Pulse ( $P_D$ )   | 288 W         |

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

## RF Characterization – Load Pull Performance at 1.0 GHz <sup>(1)</sup>

Test conditions unless otherwise noted:  $T_A = 25$  °C,  $V_D = 36$  V,  $I_{DQ} = 576$  mA

| Symbol      | Parameter                                 | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| $G_{LIN}$   | Linear Gain                               |     | 20.8    |     | dB    |
| $P_{3dB}$   | Output Power at 3 dB Gain Compression     |     | 316.0   |     | W     |
| $DE_{3dB}$  | Drain Efficiency at 3 dB Gain Compression |     | 66.7    |     | %     |
| $PAE_{3dB}$ | Power-Added Efficiency at 3 dB Gain       |     | 65.6    |     | %     |
| $G_{3dB}$   | Gain at 3 dB Compression                  |     | 17.8    |     | dB    |

Notes:

1.  $V_{DS} = 36$  V,  $I_{DQ} = 576$  mA; Pulse: 300μs, 10%

## RF Characterization – Load Pull Performance at 2.0 GHz <sup>(1)</sup>

Test conditions unless otherwise noted:  $T_A = 25$  °C,  $V_D = 36$  V,  $I_{DQ} = 576$  mA

| Symbol      | Parameter                                 | Min | Typical | Max | Units |
|-------------|---|-----|---------|-----|-------|
| $G_{LIN}$   | Linear Gain                               |     | 19.4    |     | dB    |
| $P_{3dB}$   | Output Power at 3 dB Gain Compression     |     | 268.9   |     | W     |
| $DE_{3dB}$  | Drain Efficiency at 3 dB Gain Compression |     | 56.3    |     | %     |
| $PAE_{3dB}$ | Power-Added Efficiency at 3 dB Gain       |     | 55.1    |     | %     |
| $G_{3dB}$   | Gain at 3 dB Compression                  |     | 16.4    |     | dB    |

Notes:

1.  $V_{DS} = 36$  V,  $I_{DQ} = 576$  mA; Pulse: 300μs, 10%

## RF Characterization – Performance at 1.2 GHz <sup>(1, 2)</sup>

Test conditions unless otherwise noted:  $T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_D = 36\text{ V}$ ,  $I_{DQ} = 576\text{ mA}$

| Symbol     | Parameter                                 | Min   | Typical | Max | Units |
|------------|---|-------|---------|-----|-------|
| $G_{LIN}$  | Linear Gain                               | 17.0  | 18.7    |     | dB    |
| $P_{3dB}$  | Output Power at 3 dB Gain Compression     | 230.0 | 264.5   |     | W     |
| $DE_{3dB}$ | Drain Efficiency at 3 dB Gain Compression | 49.0  | 54.0    |     | %     |
| $G_{3dB}$  | Gain at 3 dB Compression                  | 14.0  | 15.7    |     | dB    |

Notes:

1. Performance at 1.2 GHz in the 1.2 to 1.4 GHz Evaluation Board
2.  $V_{DS} = 36\text{ V}$ ,  $I_{DQ} = 576\text{ mA}$ ; Pulse: 300 $\mu\text{s}$ , 10%

## RF Characterization – Narrow Band Performance at 1.2 GHz <sup>(1)</sup>

Test conditions unless otherwise noted:  $T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_D = 36\text{ V}$ ,  $I_{DQ} = 576\text{ mA}$

| Symbol | Parameter                     | Typical |
|--------|-------------------------------|---------|
| VSWR   | Impedance Mismatch Ruggedness | 10:1    |

Notes:

1.  $V_{DS} = 36\text{ V}$ ,  $I_{DQ} = 576\text{ mA}$ , CW at  $P_{1dB}$

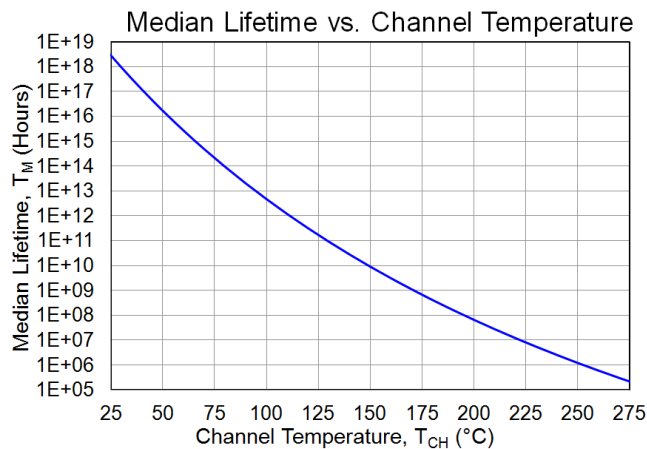
## Thermal and Reliability Information

| Parameter                            | Test Conditions  | Value | Units |
|--------------------------------------|--|-------|-------|
| Thermal Resistance ( $\theta_{JC}$ ) | Vd = 36V, DC at 85°C Case<br>CW                        | 0.73  | °C/W  |
| Channel Temperature ( $T_{CH}$ )     |  | 250   | °C    |
| Thermal Resistance ( $\theta_{JC}$ ) | Vd = 36 V, DC at 85°C Case<br>100 usec, 10% duty cycle | 0.36  | °C/W  |
| Channel Temperature ( $T_{CH}$ )     |  | 167   | °C    |
| Thermal Resistance ( $\theta_{JC}$ ) | Vd = 32 V, DC at 85°C Case<br>100 usec, 20% duty cycle | 0.39  | °C/W  |
| Channel Temperature ( $T_{CH}$ )     |  | 175   | °C    |
| Thermal Resistance ( $\theta_{JC}$ ) | Vd = 32 V, DC at 85°C Case<br>300 usec, 10% duty cycle | 0.43  | °C/W  |
| Channel Temperature ( $T_{CH}$ )     |  | 184   | °C    |
| Thermal Resistance ( $\theta_{JC}$ ) | Vd = 32 V, DC at 85°C Case<br>300 usec, 20% duty cycle | 0.46  | °C/W  |
| Channel Temperature ( $T_{CH}$ )     |  | 192   | °C    |

Notes:

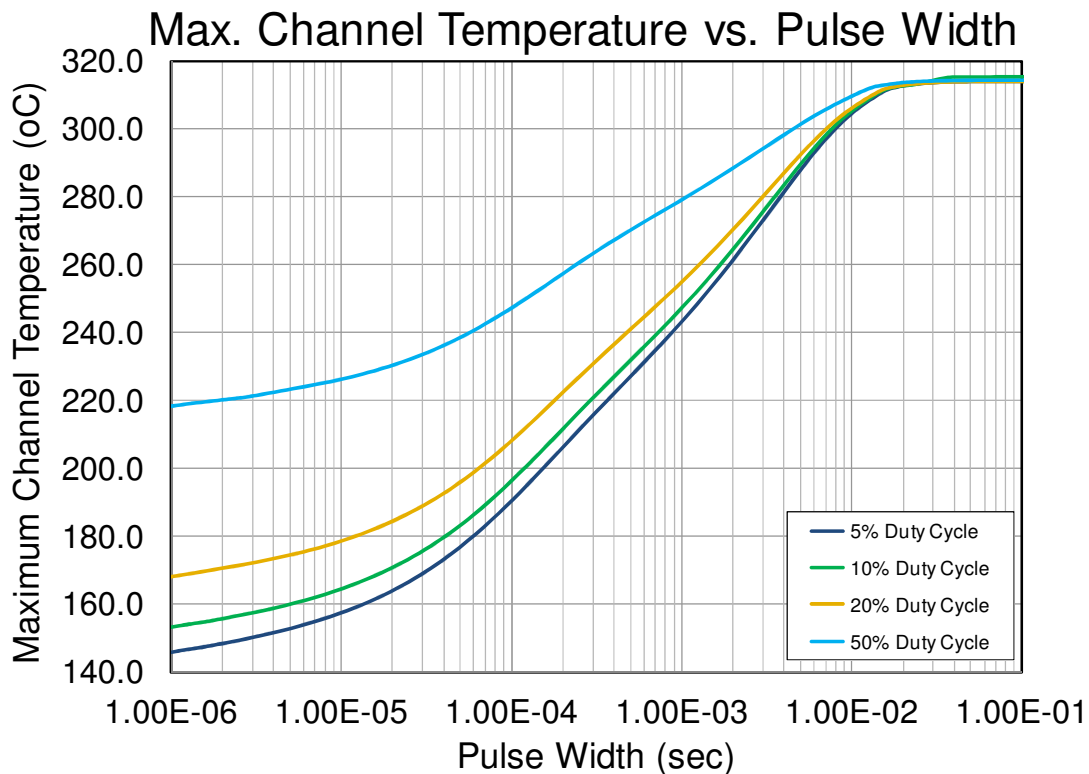
Thermal resistance measured to bottom of package

## Median Lifetime



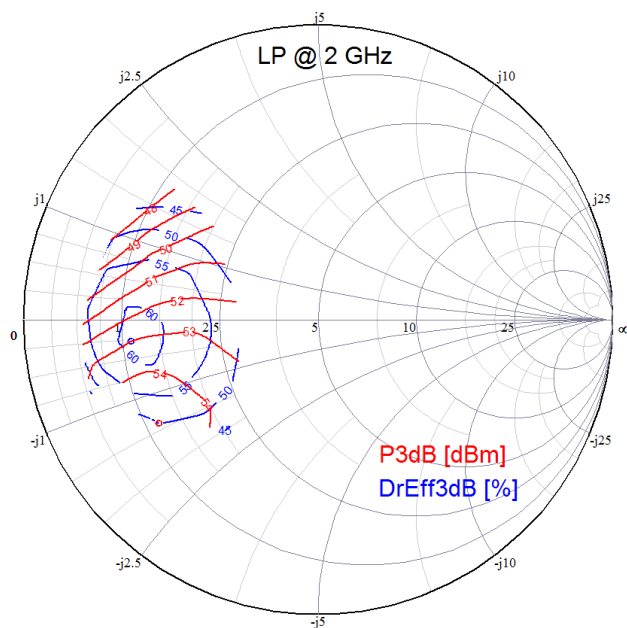
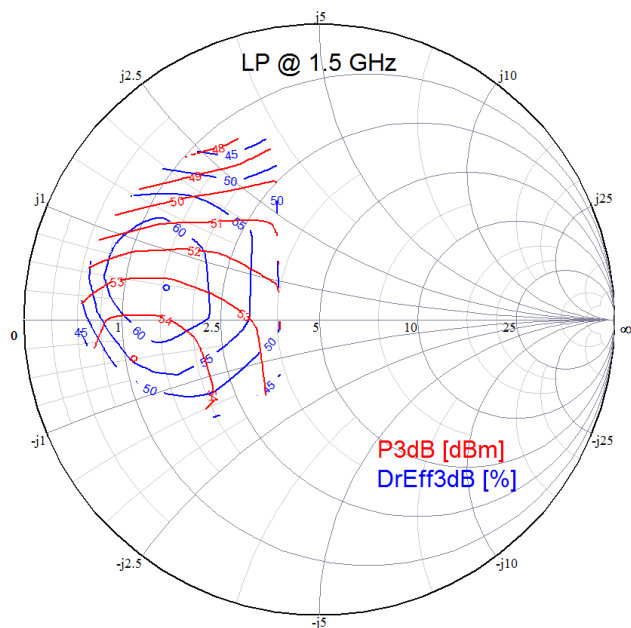
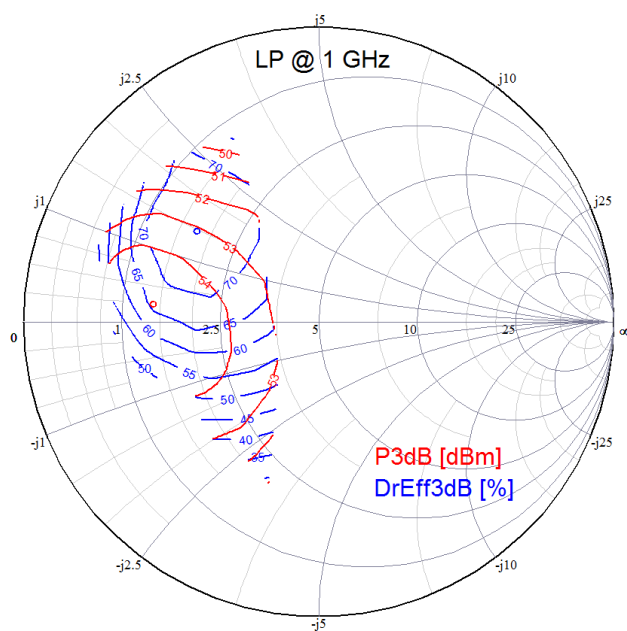
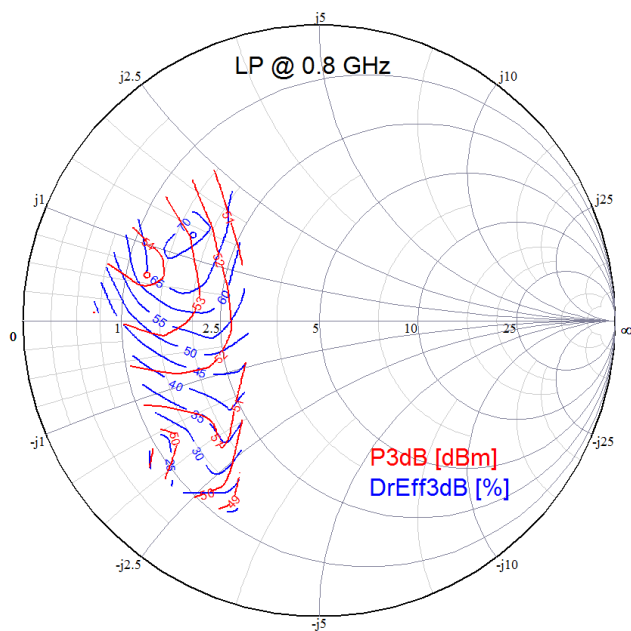
## Maximum Channel Temperature

$T_{BASE} = 85^\circ\text{C}$ ,  $P_D = 288\text{ W}$



## Load Pull Smith Charts <sup>(1, 2)</sup>

RF performance that the device typically exhibits when placed in the specified impedance environment. The impedances are not the impedances of the device, they are the impedances presented to the device via an RF circuit or load-pull system. The impedances listed follow an optimized trajectory to maintain high power and high efficiency.

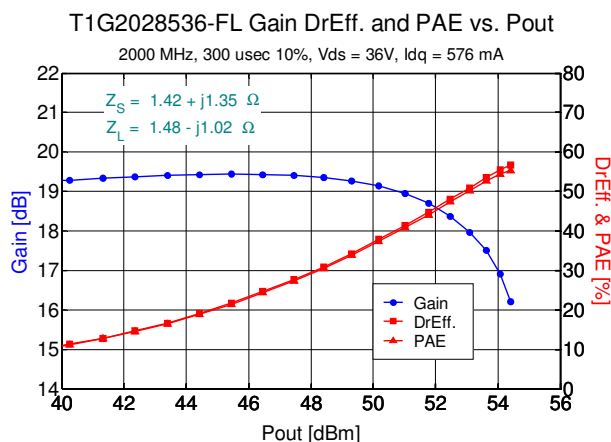
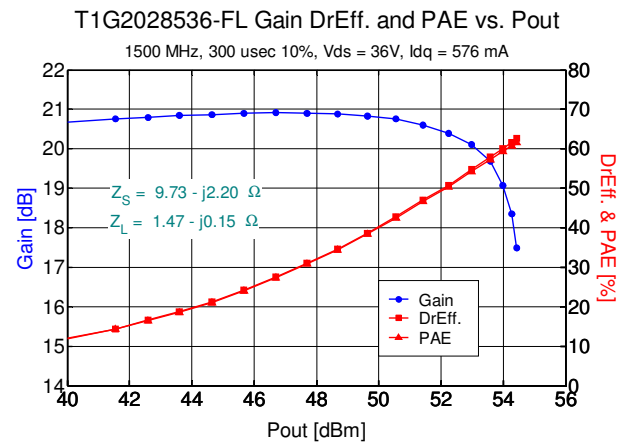
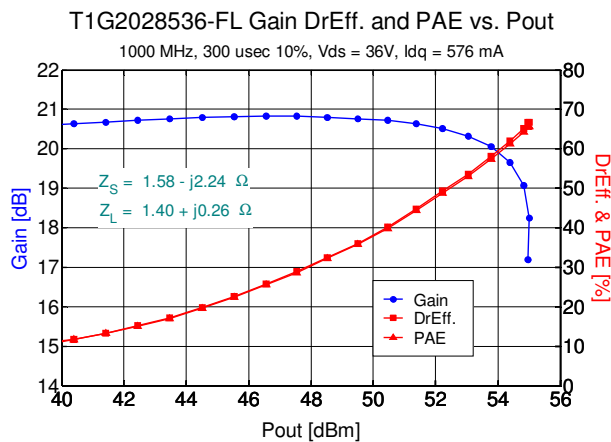
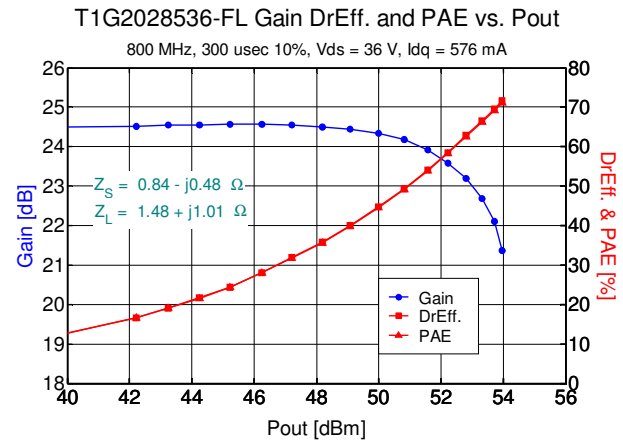
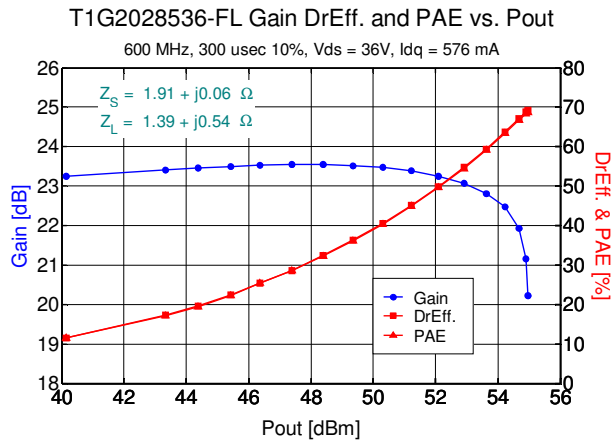


### Notes:

1. Test Conditions:  $V_{DS} = 36\text{ V}$ ,  $I_{DQ} = 576\text{ mA}$
2. Test Signal: Pulse Width = 100  $\mu\text{sec}$ , Duty Cycle = 20%

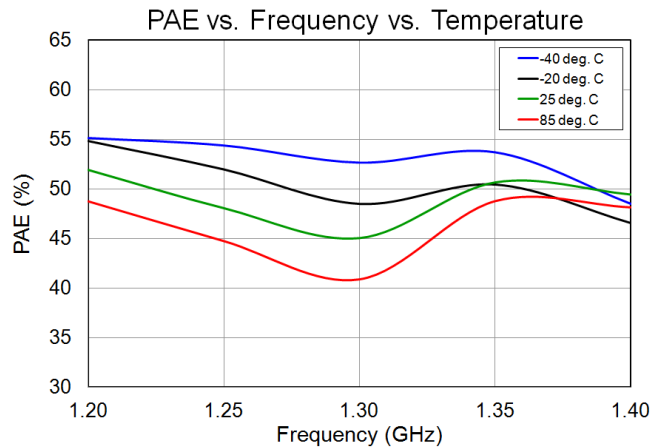
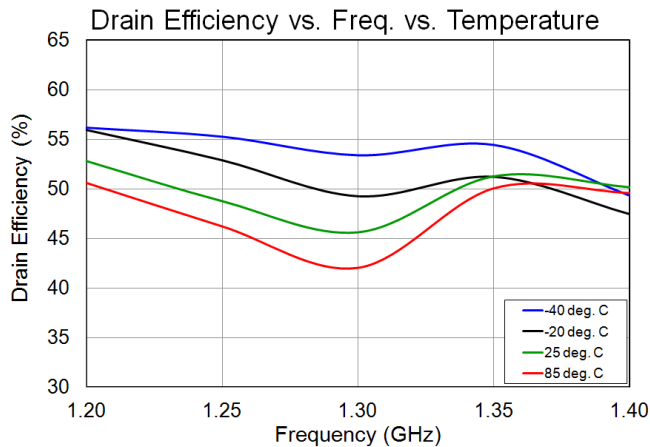
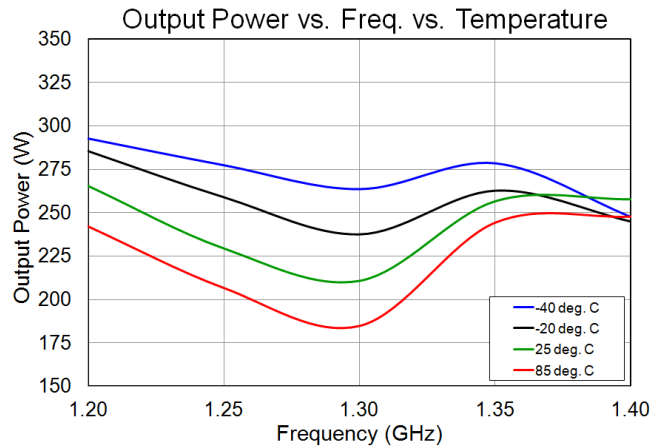
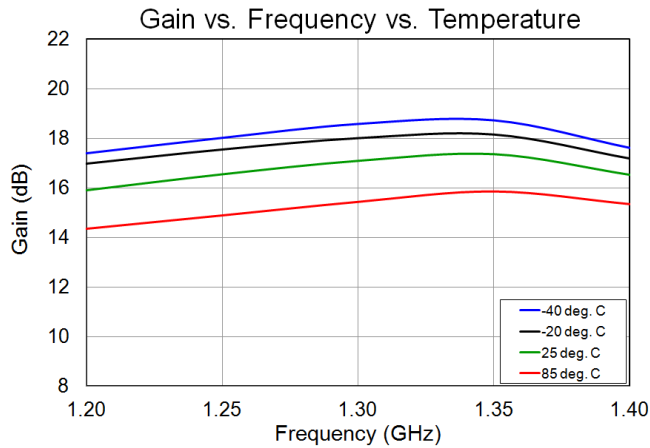
## Typical Performance

Performance is based on compromised impedance point and measured at DUT reference plane.



## Performance Over Temperature <sup>(1, 2)</sup>

Performance measured in TriQuint's 1.2 GHz to 1.4 GHz Evaluation Board at 3 dB compression.



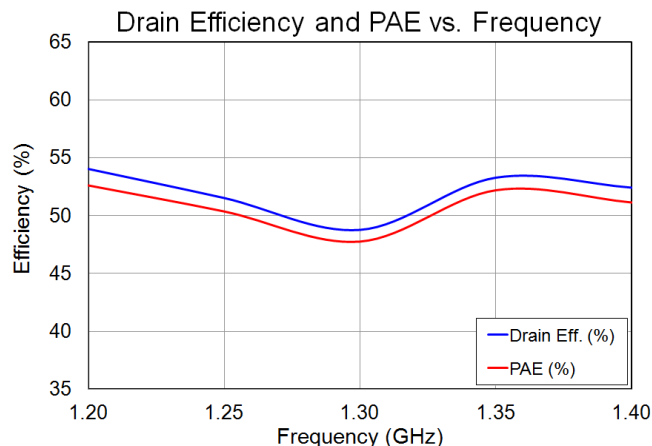
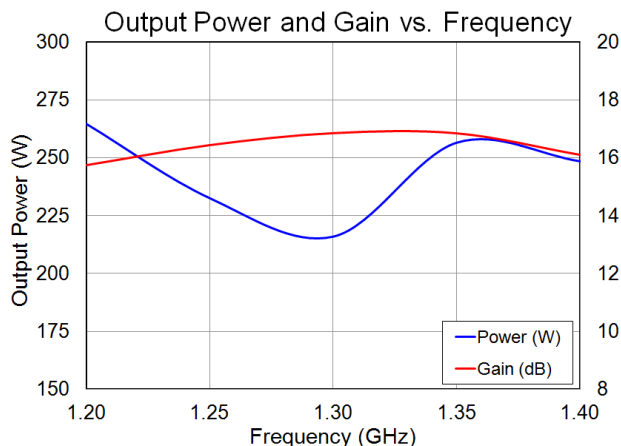
### Notes:

1. Test Conditions:  $V_{DS} = 36\text{ V}$ ,  $I_{DQ} = 576\text{ mA}$
2. Test Signal: Pulse Width = 300  $\mu\text{s}$ , Duty Cycle = 10%



## Evaluation Board Performance <sup>(1, 2)</sup>

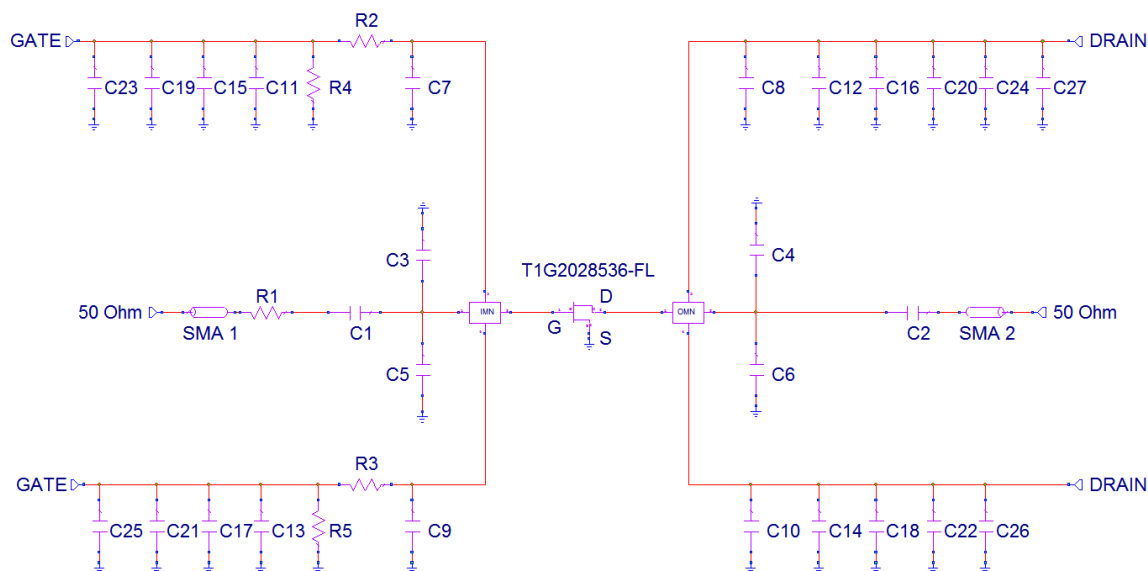
Performance at 3 dB Compression



Notes:

1. Test Conditions:  $V_{DS} = 36$  V,  $I_{DQ} = 576$  mA
2. Test Signal: Pulse Width = 300  $\mu$ s, Duty Cycle = 10 %

## Application Circuit



## Bias-up Procedure

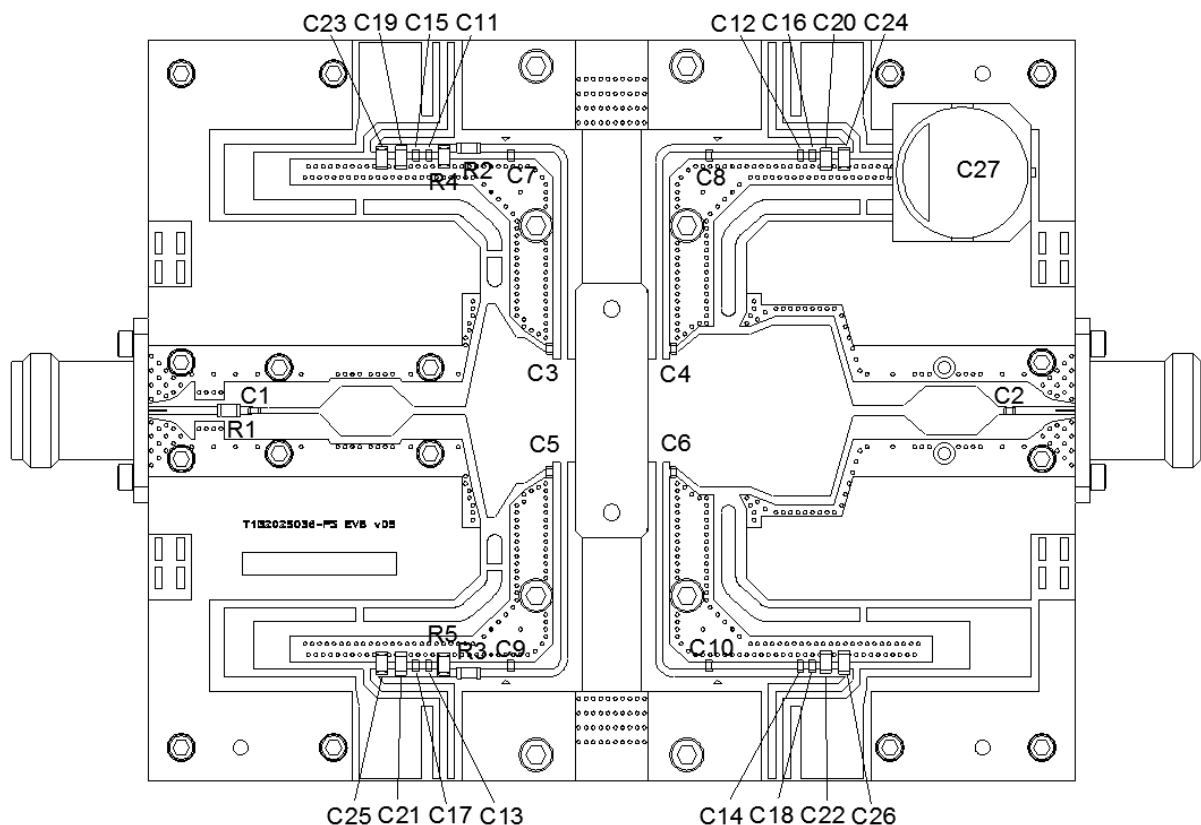
1. Set gate voltage ( $V_G$ ) to -5.0V
2. Set drain voltage ( $V_D$ ) to 36 V
3. Slowly increase  $V_G$  until quiescent  $I_D$  is 576 mA.
4. Apply RF signal

## Bias-down Procedure

1. Turn off RF signal
2. Turn off  $V_D$  and wait 1 second to allow drain capacitor dissipation
3. Turn off  $V_G$

## Evaluation Board Layout

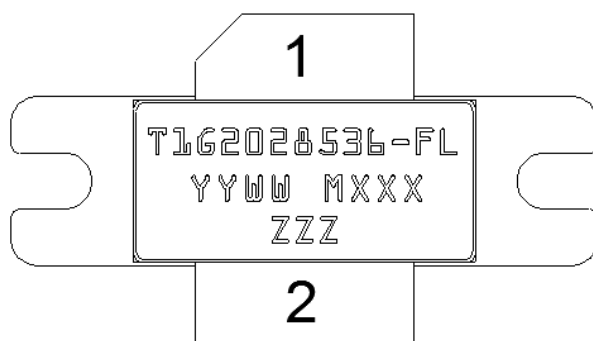
Top RF layer is 0.020" thick Rogers RO4350,  $\epsilon_r = 3.48$ . The pad pattern shown has been developed and tested for optimized assembly at TriQuint Semiconductor. The PCB land pattern has been developed to accommodate lead and package tolerances.



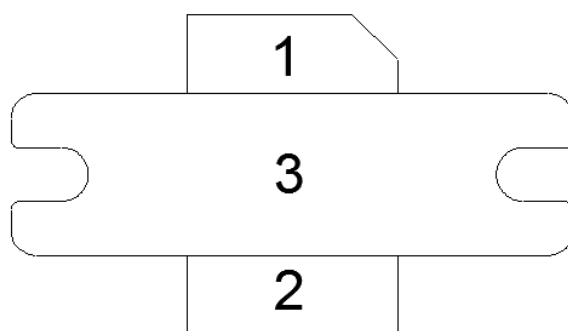
## Bill of Materials

| Reference Design        | Value     | Qty | Manufacturer     | Part Number       |
|-------------------------|-----------|-----|------------------|-------------------|
| C1, C2, C7, C8, C9, C10 | 27 pF     | 6   | ATC              | 600S270FW250XT    |
| C3, C5                  | 3.9 pF    | 2   | ATC              | 600S3R9AW250XT    |
| C4, C6                  | 4.7 pF    | 2   | ATC              | 600S4R7AW250XT    |
| C11, C12, C13, C14      | 2400 pF   | 4   | Murata           | C08BL242X-5UN-X0T |
| C15, C16, C17, C18      | 100 pF    | 4   | ATC              | 600S101FW250XT    |
| C19, C20, C21, C22      | 0.01 uF   | 4   | Kemet            | C1206C103KRAC7800 |
| C23, C24, C25, C26      | 1 uF      | 4   | Allied           | 18121C105KAT2A    |
| C27                     | 330 uF    | 1   | Cornell Dubilier | AFK337M2AR44T-F   |
| R1, R2, R3              | 12.1 ohms | 3   | Vishay Dale      | CRCW120612R1FKTA  |
| R4, R5                  | 1000 ohms | 2   | Vishay Dale      | CRCW12061K00FKTA  |

## Pin Layout



TOP VIEW



BOTTOM VIEW

**Note:**

The T1G2028536-FL will be marked with the “T1G2028536-FL” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, the “MXXX” is the production lot number, and the “ZZZ” is an auto-generated serial number.

## Pin Description

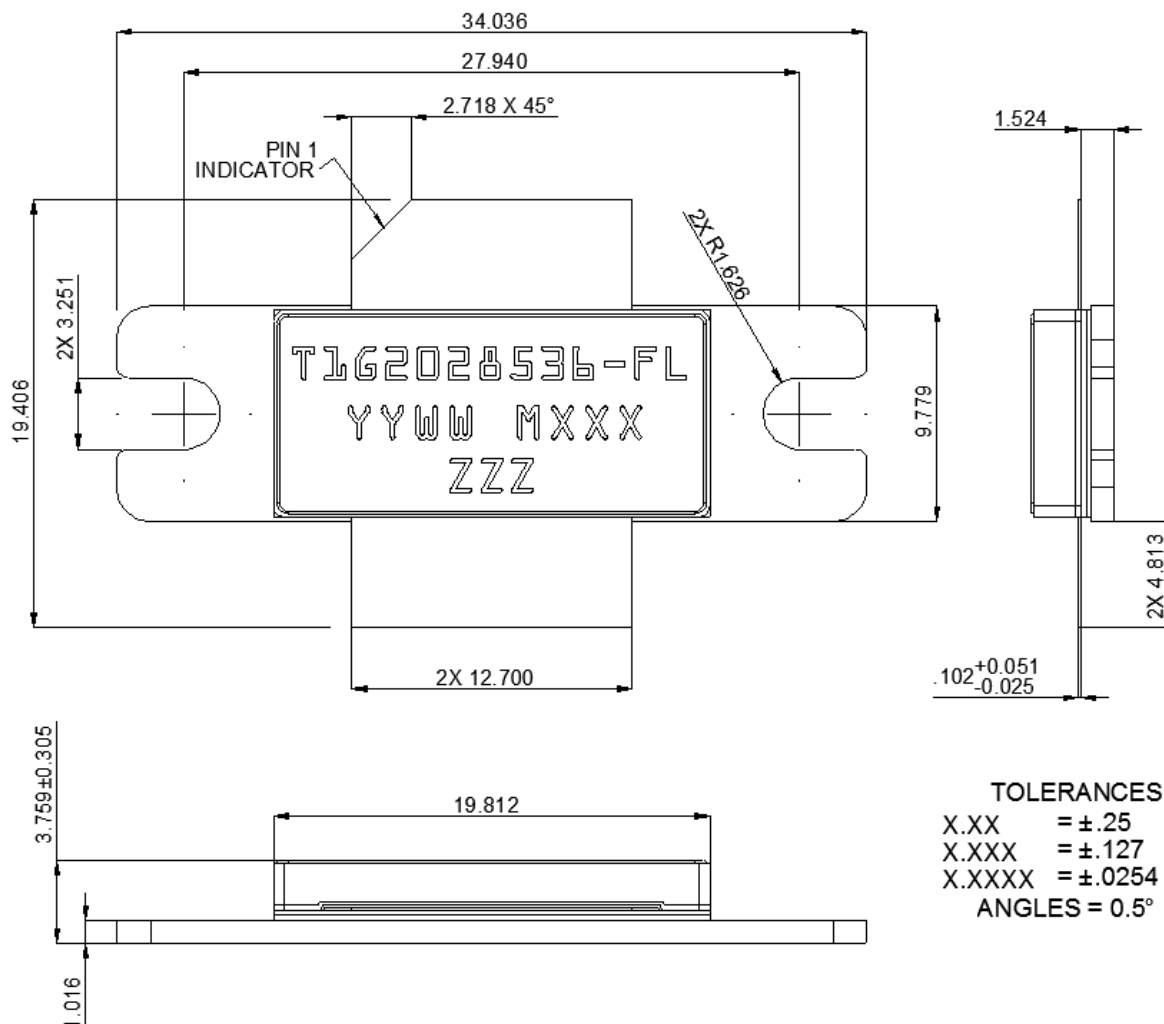
| Pin | Symbol         | Description  |
|-----|----------------|--|
| 1   | $V_D$ / RF OUT | Drain voltage / RF Output matched to 50 ohms; see EVB Layout on page 10 as an example. |
| 2   | $V_G$ / RF IN  | Gate voltage / RF Input matched to 50 ohms; see EVB Layout on page 10 as an example.   |
| 3   | Flange         | Source connected to ground; see EVB Layout on page 10 as an example.                   |

**Notes:**

Thermal resistance measured to bottom of package

## Mechanical Information

All dimensions are in millimeters.



**Note:**

This package is lead-free/RoHS-compliant. The plating material on the leads is NiAu. It is compatible with both lead-free (maximum 260 °C reflow temperature) and tin-lead (maximum 245 °C reflow temperature) soldering processes.

## Product Compliance Information

### ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: TBD  
Value: TBD  
Test: Human Body Model (HBM)  
Standard: JEDEC Standard JESD22-A114

### MSL Rating

Level 3 at +260 °C convection reflow  
The part is rated Moisture Sensitivity Level 3 at 260°C per JEDEC standard IPC/JEDEC J-STD-020.

### Solderability

Compatible with the latest version of J-STD-020, Lead free solder, 260° C

### RoHS Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

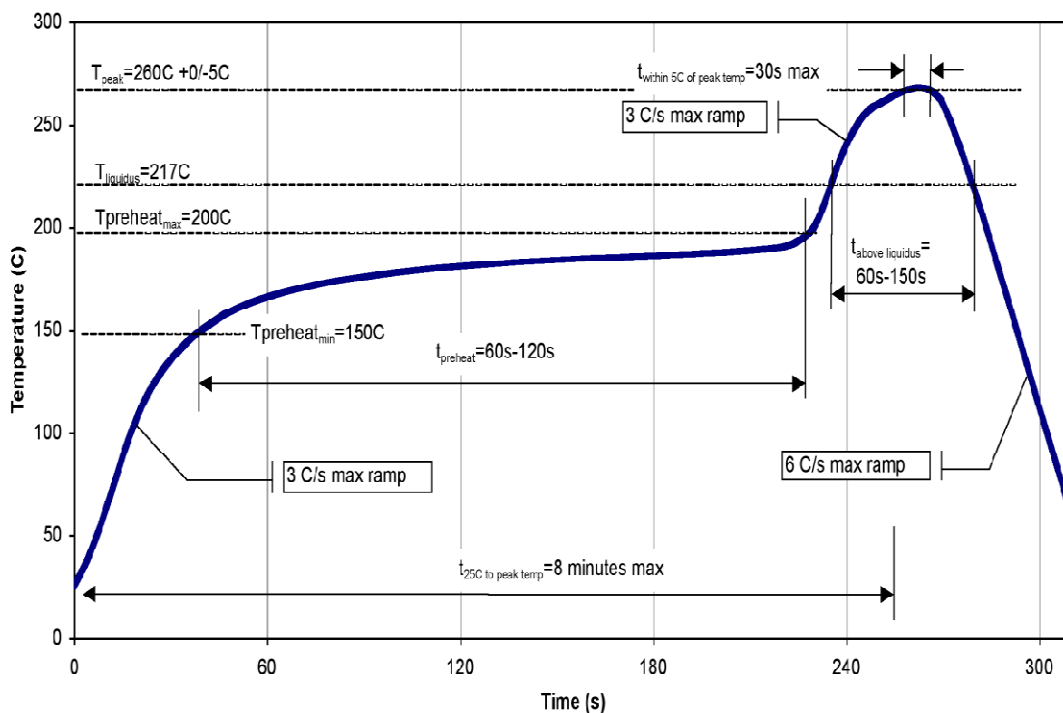
This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ( $C_{15}H_{12}Br_4O_2$ ) Free
- PFOS Free
- SVHC Free

### ECCN

US Department of Commerce EAR99

## Recommended Soldering Temperature Profile



## Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

**Web:** [www.triquint.com](http://www.triquint.com)

**Email:** [info-sales@triquint.com](mailto:info-sales@triquint.com)

**Tel:** +1.972.994.8465

**Fax:** +1.972.994.8504

For technical questions and application information:

**Email:** [info-products@triquint.com](mailto:info-products@triquint.com)

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